COS/MOS
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INTEGRATED
7929237 0014964 7
CIRCUITS

HCC/HCF 4510B
HCC/HCF 4516B

41C 08978 D

PRESETTABLE UP/DOWN COUNTERS

- MEDIUM SPEED OPERATION $f_{CL} = 8$ MHz TYP. AT 10V
- SYNCHRONOUS INTERNAL CARRY PROPAGATION
- RESET AND PRESET CAPABILITY
- QUIESCENT CURRENT SPECIFIED TO 20V FOR HCC DEVICE
- 5V, 10V, AND 15V PARAMETRIC RATINGS
- INPUT CURRENT OF 100 nA AT 18V AND 25°C FOR HCC DEVICE
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC TENTATIVE STANDARD No. 13A, "STANDARD SPECIFICATIONS FOR DESCRIPTION OF "B" SERIES CMOS DEVICES"

The **HCC 4510B, HCC 4516B** (extended temperature range) and the **HCF 4510B, HCF 4516B** (intermediate temperature range) are monolithic integrated circuits available in 16-lead dual in-line plastic or ceramic package and ceramic flat package. The **HCC/HCF 4510B** Presettable BCD Up/Down Counter and the **HCC/HCF 4516B** Presettable Binary Up/Down Counter consist of four synchronously clocked D-type flip-flops (with a gating structure to provide T-type flip-flop capability) connected as counters. These counters can be cleared by a high level on the RESET line, and can be preset to any binary number present on the jam inputs by a high level on the PRESET ENABLE line. The **HCC/HCF 4510B** will count out of non-BCD counter states in a maximum of two clock pulses in the up mode, and a maximum of four clock pulses in the down mode. If the CARRY-IN input is held low, the counter advances up or down on each positive-going clock transition. Synchronous cascading is accomplished by connecting all clock inputs in parallel and connecting the CARRY-OUT of a less significant stage to the CARRY-IN of a more significant stage. The **HCC/HCF 4510B** and **HCC/HCF 4516B** can be cascaded in the ripple mode by connecting the CARRY-OUT to the clock of the next stage. If the UP/DOWN input changes during a terminal count, the CARRY-OUT must be gated with the clock, and the UP/DOWN input must change while the clock is high. This method provides a clean clock signal to the subsequent counting stage.

ABSOLUTE MAXIMUM RATINGS

V_{DD} *	Supply voltage: **HCC** types	-0.5 to 20	V
	HCF types	-0.5 to 18	V
V_I	Input voltage	-0.5 to V_{DD} +0.5	V
I_I	DC input current (any one input)	± 10	mA
P_{tot}	Total power dissipation (per package)	200	mW
	Dissipation per output transistor		
	for T_{op} = full package-temperature range	100	mW
T_{op}	Operating temperature: **HCC** types	-55 to 125	°C
	HCF types	-40 to 85	°C
T_{stg}	Storage temperature	-65 to 150	°C

* All voltage values are referred to V_{SS} pin voltage

ORDERING NUMBERS:

HCC 45XX BD for dual in-line ceramic package
HCC 45XX BF for dual in-line ceramic package, frit seal
HCC 45XX BK for ceramic flat package
HCF 45XX BE for dual in-line plastic package
HCF 45XX BF for dual in-line ceramic package, frit seal

HCC/HCF 4510B
HCC/HCF 4516B

41C 08979 D

MECHANICAL DATA (dimensions in mm)

Dual in-line ceramic package
for HCC 45XX BD

Dual in-line ceramic package
for HCC/HCF 45XX BF

Dual in-line plastic package
for HCF 45XX BE

Ceramic flat package
for HCC 45XX BK

CONNECTION DIAGRAMS


```
PRESET       ⌽1      16⌽ V_DD
ENABLE
Q4           ⌽2      15⌽ CLOCK
P4           ⌽3      14⌽ Q3
P1           ⌽4      13⌽ P3
CARRY IN     ⌽5      12⌽ P2
Q1           ⌽6      11⌽ Q2
CARRY OUT    ⌽7      10⌽ UP/DOWN
V_SS         ⌽8       9⌽ RESET
```
S-2779

FUNCTIONAL DIAGRAM


```
PRESET ENABLE ──── 1
P1       4              6   Q1
P2      12             11   Q2
P3      13             14   Q3
P4       3              2   Q4
CLOCK   15
UP/DOWN 10
CARRY IN 5 ○        ○ 7  CARRY OUT
                9
RESET
                    V_DD = 16
                    V_SS = 8
```
S-2778

RECOMMENDED OPERATING CONDITIONS

V_{DD}	Supply voltage: HCC types	3 to 18	V
	HCF types	3 to 15	V
V_I	Input voltage	0 to V_{DD}	V
T_{op}	Operating temperature: HCC types	-55 to 125	°C
	HCF types	-40 to 85	°C

HCC/HCF 4510B
HCC/HCF 4516B

41C 08980   D

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LOGIC DIAGRAMS

for **HCC/HCF 4510B**
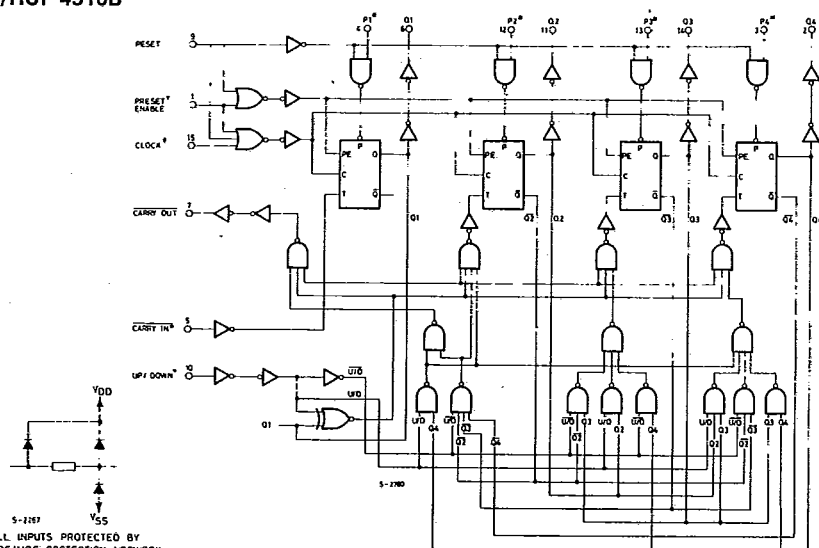
ALL INPUTS PROTECTED BY
COS/MOS PROTECTION NETWORK

for **HCC/HCF 4516B**

ALL INPUTS PROTECTED BY
COS/MOS PROTECTION NETWORK

HCC/HCF 4510B
HCC/HCF 4516B

TIMING DIAGRAMS AND TRUTH TABLE

for HCC/HCF 4510B
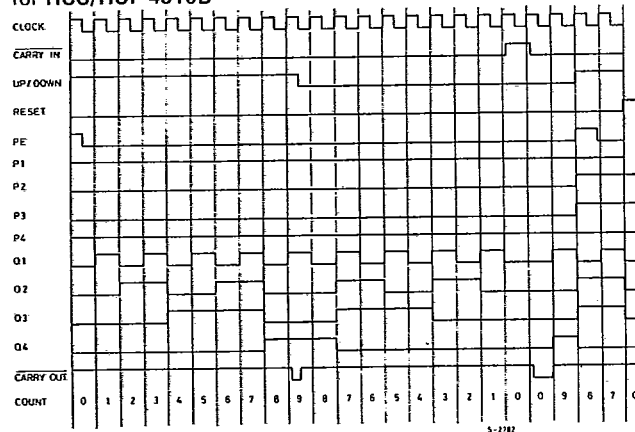
CL	CI	U/D	PE	R	ACTION
X	1	X	0	0	NO COUNT
⌐	0	1	0	0	COUNT UP
⌐	0	0	0	0	COUNT DOWN
X	X	X	1	0	PRESET
X	X	X	X	1	RESET

X = Don't care

for HCC/HCF 4516B

Power dissipation and input waveform
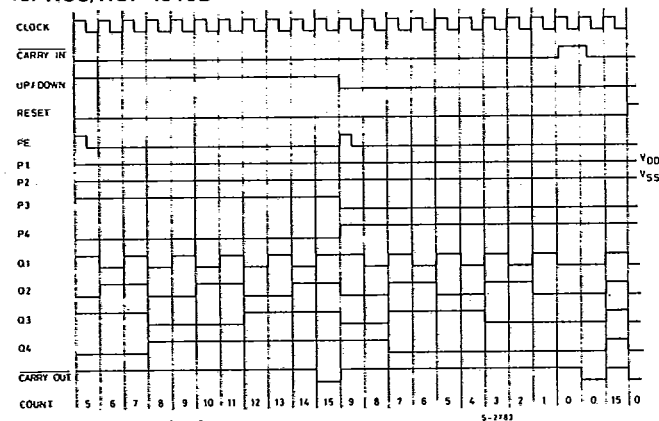
TEST CIRCUITS

Quiescent device current
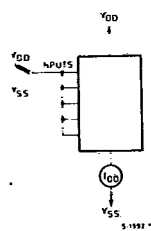
Noise immunity

Input leakage current
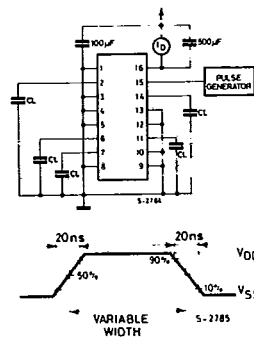
HCC/HCF 4510B
HCC/HCF 4516B

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STATIC ELECTRICAL CHARACTERISTICS (over recommended operating conditions)

Parameter			Test conditions				Values							Unit
			V_I (V)	V_O (V)	$|I_O|$ (µA)	V_{DD} (V)	T_{Low}* Min.	T_{Low}* Max.	25°C Min.	25°C Typ.	25°C Max.	T_{High}* Min.	T_{High}* Max.	
I_L	Quiescent current	HCC types	0/ 5			5		5		0.04	5		150	µA
			0/10			10		10		0.04	10		300	
			0/15			15		20		0.04	20		600	
			0/20			20		100		0.08	100		3000	
		HCF types	0/ 5			5		20		0.04	20		150	
			0/10			10		40		0.04	40		300	
			0/15			15		80		0.04	80		600	
V_{OH}	Output high voltage		0/ 5		<1	5	4.95		4.95			4.95		V
			0/10		<1	10	9.95		9.95			9.95		
			0/15		<1	15	14.95		14.95			14.95		
V_{OL}	Output low voltage		5/0		<1	5		0.05			0.05		0.05	V
			10/0		<1	10		0.05			0.05		0.05	
			15/0		<1	15		0.05			0.05		0.05	
V_{IH}	Input high voltage			0.5/4.5	<1	5	3.5		3.5			3.5		V
				1/9	<1	10	7		7			7		
				1.5/13.5	<1	15	11		11			11		
V_{IL}	Input low voltage			4.5/0.5	<1	5		1.5			1.5		1.5	V
				9/1	<1	10		3			3		3	
				13.5/1.5	<1	15		4			4		4	
I_{OH}	Output drive current	HCC types	0/ 5	2.5		5	-2		-1.6	-3.2		-1.15		mA
			0/ 5	4.6		5	-0.64		-0.51	-1		-0.36		
			0/10	9.5		10	-1.6		-1.3	-2.6		-0.9		
			0/15	13.5		15	-4.2		-3.4	-6.8		-2.4		
		HCF types	0/ 5	2.5		5	-1.53		-1.36	-3.2		-1.1		
			0/ 5	4.6		5	-0.52		-0.44	-1		-0.36		
			0/10	9.5		10	-1.3		-1.1	-2.6		-0.9		
			0/15	13.5		15	-3.6		-3.0	-6.8		-2.4		
I_{OL}	Output sink current	HCC types	0/ 5	0.4		5	0.64		0.51	1		0.36		mA
			0/10	0.5		10	1.6		1.3	2.6		0.9		
			0/15	1.5		15	4.2		3.4	6.8		2.4		
		HCF types	0/ 5	0.4		5	0.52		0.44	1		0.36		
			0/10	0.5		10	1.3		1.1	2.6		0.9		
			0/15	1.5		15	3.6		3.0	6.8		2.4		
I_{IH}, I_{IL}	Input leakage current	HCC types	0/18	Any input		18		±0.1	±10^{-5}	±0.1			±1	µA
		HCF types	0/15			15		±0.3	±10^{-5}	±0.3			±1	
C_I	Input capacitance			Any input						5	7.5			pF

* T_{Low} = – 55°C for **HCC** device: –40°C for **HCF** device.
* T_{High} = +125°C for **HCC** device: +85°C for **HCF** device.
  The Noise Margin for both "1" and "0" level is: 1V min. with V_{DD}= 5V
                                                    2V min. with V_{DD}= 10V
                                                    2.5V min. with V_{DD}= 15V

HCC/HCF 4510B
HCC/HCF 4516B

41C 08983   D

DYNAMIC ELECTRICAL CHARACTERISTICS   (T_{amb}= 25°C, C_L= 50 pF, R_L= 200 kΩ, typical temperature coefficient for all V_{DD} values is 0.3%/°C, all input rise and fall times = 20 ns)

Parameter		Test conditions	Values			Unit
		V_{DD} (V)	Min.	Typ.	Max.	
t_{PHL}, t_{PLH}	Propagation delay time clock to Q output	5		200	400	ns
		10		100	200	
		15		75	150	
t_{PHL}, t_{PLH}	Propagation delay time preset or reset to Q output	5		210	420	ns
		10		105	210	
		15		80	160	
t_{PHL}, t_{PLH}	Propagation delay time clock to carry out	5		240	480	ns
		10		120	240	
		15		90	180	
t_{PHL}, t_{PLH}	Propagation delay time carry in to carry out	5		125	250	ns
		10		60	120	
		15		50	100	
t_{PHL}, t_{PLH}	Propagation delay time preset or reset to carry out	5		320	640	ns
		10		160	320	
		15		125	250	
t_{THL}, t_{TLH}	Transition time	5		100	200	ns
		10		50	100	
		15		40	80	
f_{max}	Max. clock frequency	5	2	4		MHz
		10	4	8		
		15	5.5	11		
t_W	Clock pulse width	5	150			ns
		10	75			
		15	60			
	• Preset enable or reset removal time	5	150			ns
		10	80			
		15	60			
t_r t_f	∗ Clock rise and fall time	5			15	µs
		10			5	
		15			5	
t_{setup}	Carry in setup time	5	130			ns
		10	60			
		15	45			
t_{setup}	Up-down setup time	5	360			ns
		10	160			
		15	110			
t_W	Preset enable or reset pulse width	5	220			ns
		10	100			
		15	75			

● Time required after the falling edge of the reset or preset enable inputs before the rising edge of the clock will trigger the counter (similar to setup time).

∗ If more than unit is cascaded in the parallel clocked application, t_rCL should be made less than or equal to the sum of the fixed propagation delay at 15 pF and the transition time of the carry output driving stage for the estimated capacitive load.

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Typical output low (sink)
current characteristics
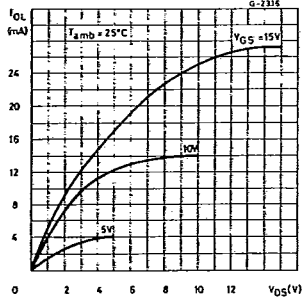
Minimum output low (sink)
current characteristics
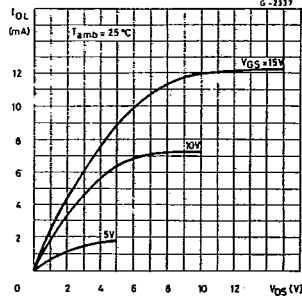
Typical output high (source)
current characteristics
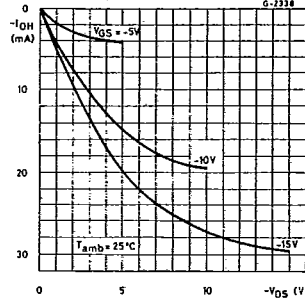
Minimum output high
(source) current character-
istics
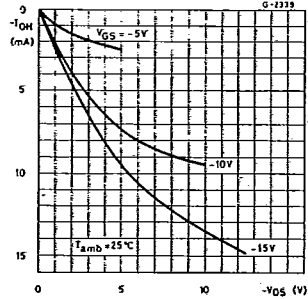
Typical propagation delay
time vs. load capacitance for
clock to Q output
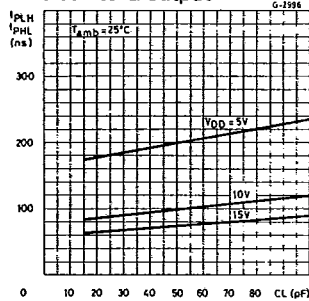
Typical maximum clock
input frequency vs. supply
voltage
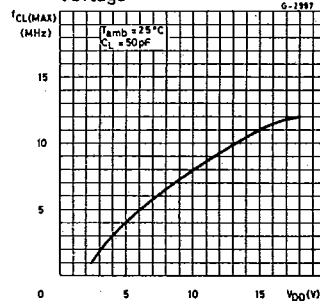
Typical transition time vs.
load capacitance
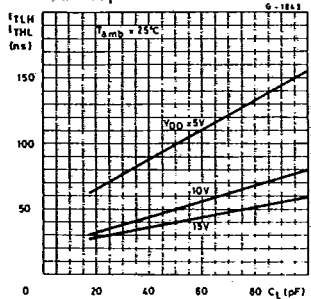
Typical dynamic power dis-
sipation vs. frequency
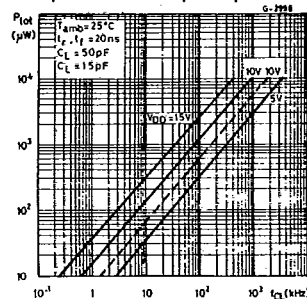
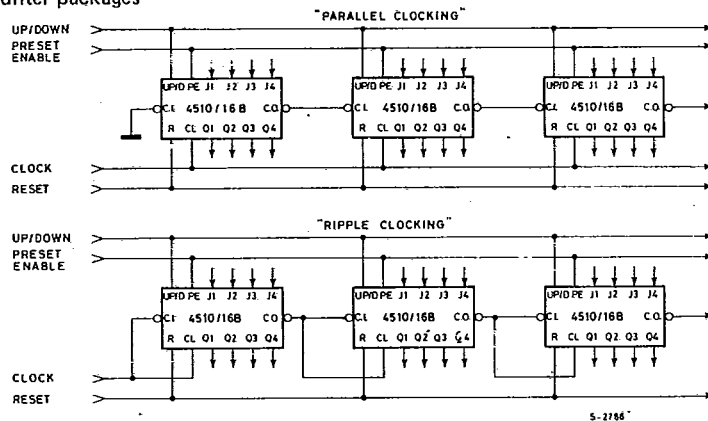**HCC/HCF 4510B**
HCC/HCF 4516B

TYPICAL APPLICATIONS

Typical 16-channel, 10 bit data aquisition system
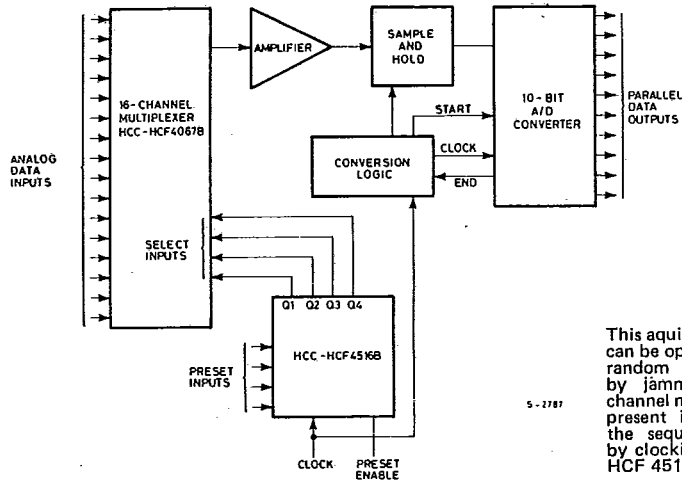
This aquisition system can be operated in the random access mode by jamming in the channel number at the present inputs, or in the sequential mode by clocking the HCC/HCF 4516B.
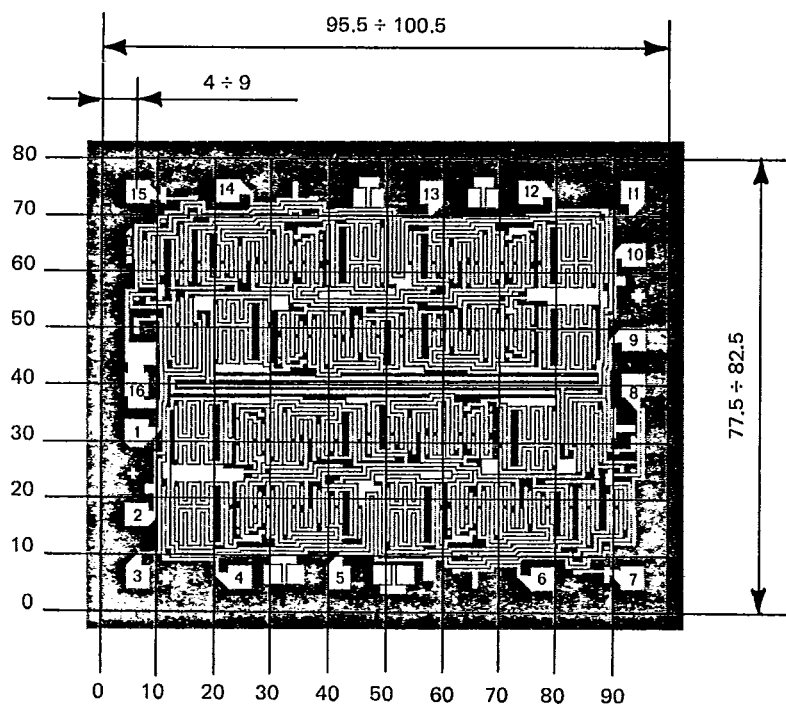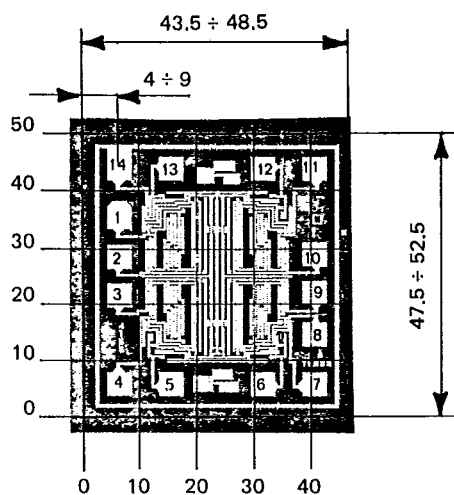
Cascading counter packages

4015B

4016B

2112   D-07   630